Se	arcn Notes

App	licatio	on/Co	ntrol	No.

10/659,076 Examiner

Mike Fatahiyar

Applicant(s)/Patent	under
Reexamination	

LEE ET AL Art Unit

2629

SEARCHED					
Class	Subclass	Date	Examiner		
345	87-104	4/28/2006	MF		
345	99, 204	4/30/2006	MF		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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